

International  
**IR** Rectifier  
**HEXFET® POWER MOSFET**

Provisional Data Sheet No. PD-9.548B

**JANTX2N6806**  
**JANTXV2N6806**  
**[REF:MIL-PRF-19500/562]**  
**[GENERIC:IRF9230]**  
**P-CHANNEL**

**-200 Volt, 0.80Ω HEXFET**

HEXFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry achieves very low on-state resistance combined with high transconductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, and high energy pulse circuits, and virtually any application where high reliability is required.

**Product Summary**

Part Number	BV <sub>DSS</sub>	R <sub>DSON</sub>	I <sub>D</sub>
JANTX2N6806	-200V	0.80Ω	-6.5A
JANTXV2N6806			

**Features:**

- Avalanche Energy Rating
- Dynamic dv/dt Rating
- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed

**Absolute Maximum Ratings**

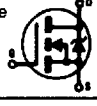
	Parameter	JANTX2N6806, JANTXV2N6806	Units
I <sub>D</sub> @ V <sub>GS</sub> = -10V, T <sub>C</sub> = 25°C	Continuous Drain Current	-6.5	A
I <sub>D</sub> @ V <sub>GS</sub> = -10V, T <sub>C</sub> = 100°C	Continuous Drain Current	-4.0	
I <sub>DM</sub>	Pulsed Drain Current ①	-28	
P <sub>D</sub> @ T <sub>C</sub> = 25°C	Max. Power Dissipation	75	W
	Linear Derating Factor	0.60	W/K ②
V <sub>GS</sub>	Gate-to-Source Voltage	±20	V
EAS	Single Pulse Avalanche Energy ②	66	mJ
I <sub>AR</sub>	Avalanche Current ①	-6.5	A
E <sub>AR</sub>	Repetitive Avalanche Energy ①	7.5	mJ
dv/dt	Peak Diode Recovery dv/dt ③	-5.0	V/ns
T <sub>J</sub>	Operating Junction	-55 to 150	°C
T <sub>STG</sub>	Storage Temperature Range		
	Lead Temperature	300 (0.063 in. (1.6mm) from case for 10.5 seconds)	
	Weight	11.5 (typical)	g

### JANTX2N6806, JANTXV2N6806 Device

#### Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
BVDSS	Drain-to-Source Breakdown Voltage	-200	—	—	V	VGS = 0V, ID = -1.0 mA
ΔBVDSS/ΔTj	Temperature Coefficient of Breakdown Voltage	—	-0.20	—	V/°C	Reference to 25°C, ID = -1.0 mA
RDS(on)	Static Drain-to-Source On-State Resistance	—	—	0.80	Ω	VGS = -10V, ID = -4.0A④
VGS(th)	Gate Threshold Voltage	-2.0	—	-4.0	V	VDS = VGS, ID = -250μA
gfs	Forward Transconductance	2.0	—	—	S (Ω)	VDS > -15V, IDS = -4.0A ④
IDSS	Zero Gate Voltage Drain Current	—	—	-25	μA	VDS = 0.8 x Max Rating, VGS = 0V
		—	—	-250	μA	VDS = 0.8 x Max Rating VGS = 0V, Tj = 125°C
IGSS	Gate-to-Source Leakage Forward	—	—	-100	nA	VGS = -20V
IGSS	Gate-to-Source Leakage Reverse	—	—	100	nA	VGS = 20V
Qg	Total Gate Charge	8	—	31	nC	VGS = -10V, ID = -6.5A
Qgs	Gate-to-Source Charge	0.8	—	7.0	nC	VDS = Max. Rating x 0.5 see figures 6 and 13
Qgd	Gate-to-Drain ("Miller") Charge	5.0	—	17	nC	
td(on)	Turn-On Delay Time	—	—	50	ns	VDD = -100V, ID = -6.5A, RG = 7.5Ω, VGS = -10V
tr	Rise Time	—	—	100	ns	
td(off)	Turn-Off Delay Time	—	—	100	ns	
tf	Fall Time	—	—	80	ns	see figure 10
LD	Internal Drain Inductance	—	5.0	—	nH	Measured from the drain lead, 6mm (0.25 in.) from package to center of die.
LS	Internal Source Inductance	—	13.0	—	nH	Measured from the source lead, 6mm (0.25 in.) from package to source bonding pad.
Ciss	Input Capacitance	—	700	—	pF	VGS = 0V, VDS = -25V
Coss	Output Capacitance	—	200	—	pF	f = 1.0 MHz
Crss	Reverse Transfer Capacitance	—	40	—	pF	see figure 5

#### Source-Drain Diode Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
IS	Continuous Source Current (Body Diode)	—	—	-6.5	A	Modified MOSFET symbol showing the integral reverse p-n junction rectifier. 
ISM	Pulse Source Current (Body Diode) ①	—	—	-28	A	
VSD	Diode Forward Voltage	—	—	-6.0	V	Tj = 25°C, IS = -6.5A, VGS = 0V ④
trr	Reverse Recovery Time	—	—	400	ns	Tj = 25°C, IF = -6.5A, di/dt ≤ -100A/μs
QRR	Reverse Recovery Charge	—	—	4.0	μC	VDD ≤ -50V ④
ton	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by LS + LD.				

#### Thermal Resistance

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
RthJC	Junction-to-Case	—	—	1.67	K/W	Typical socket mount
RthJA	Junction-to-Ambient	—	—	30		

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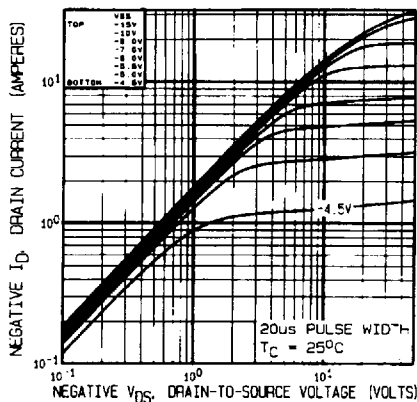


Fig. 1 — Typical Output Characteristics  
 $T_C = 25^\circ\text{C}$

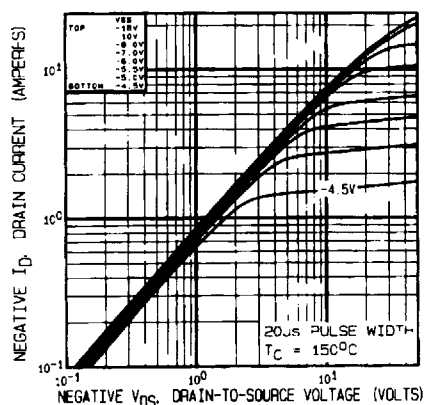


Fig. 2 — Typical Output Characteristics  
 $T_C = 150^\circ\text{C}$

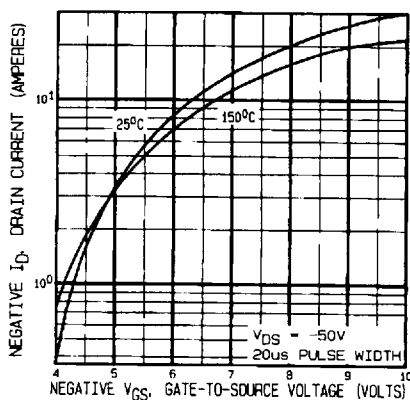


Fig. 3 — Typical Transfer Characteristics

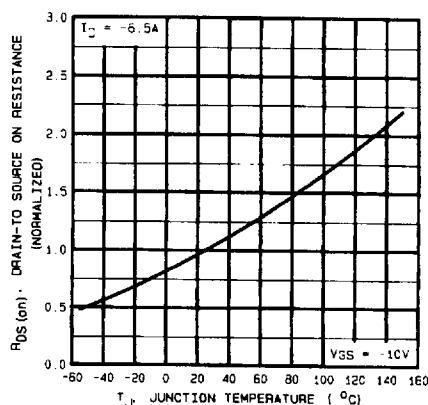


Fig. 4 — Normalized On-Resistance Vs. Temperature

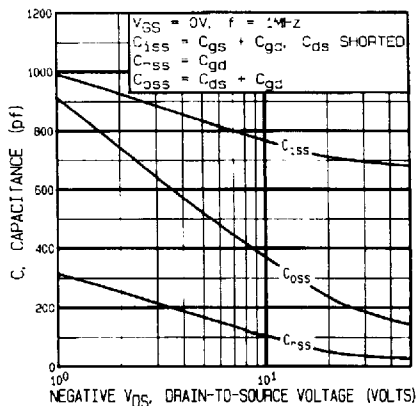


Fig. 5 — Typical Capacitance Vs. Drain-to-Source Voltage

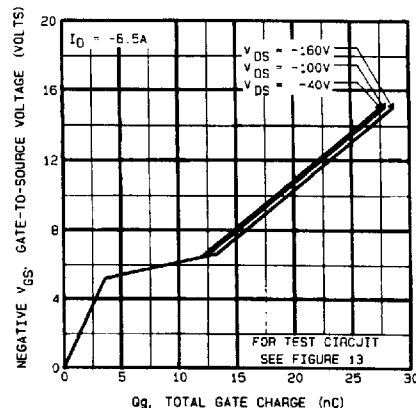


Fig. 6 — Typical Gate Charge Vs. Gate-to-Source Voltage

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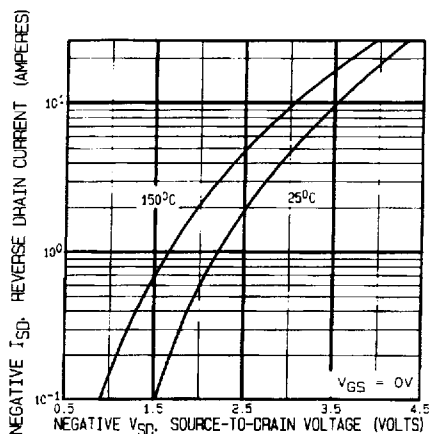


Fig. 7 — Typical Source-to-Drain Diode Forward Voltage

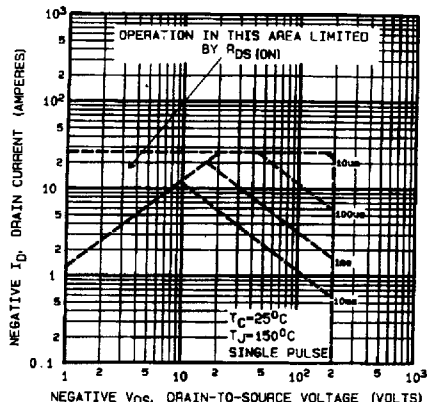


Fig. 8 — Maximum Safe Operating Area

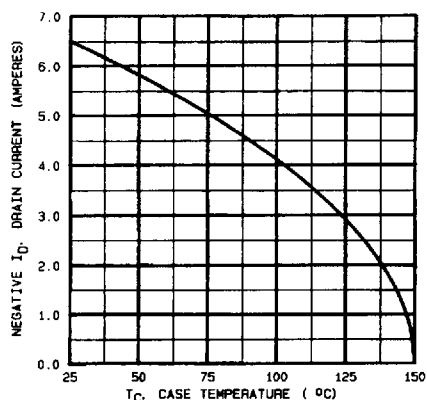


Fig. 9 — Maximum Drain Current Vs. Case Temperature

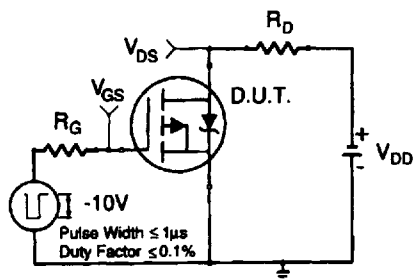


Fig. 10a — Switching Time Test Circuit

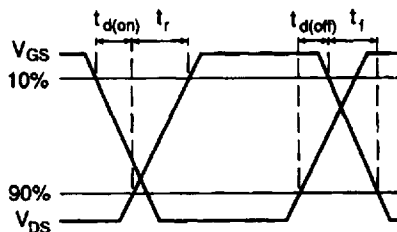


Fig. 10b — Switching Time Waveforms

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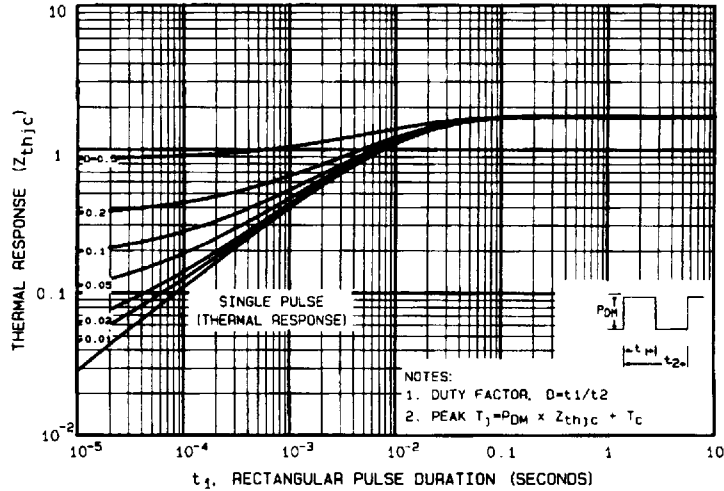


Fig. 11 — Maximum Effective Transient Thermal Impedance, Junction-to-Case Vs. Pulse Duration

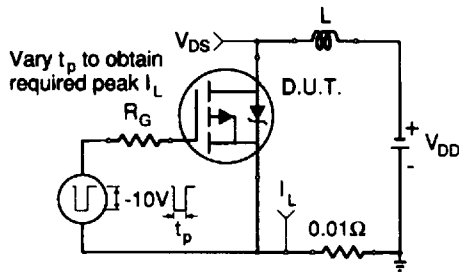


Fig. 12a — Unclamped Inductive Test Circuit

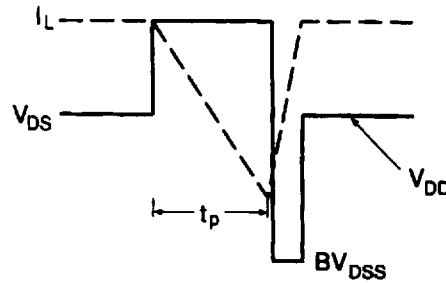


Fig. 12b — Unclamped Inductive Waveforms

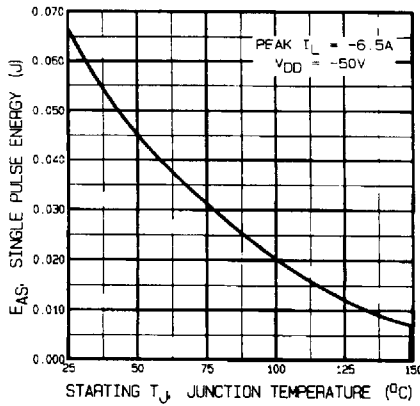


Fig. 12c — Max. Avalanche Energy vs. Current

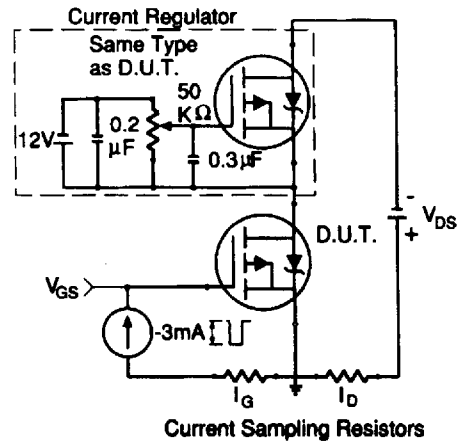


Fig. 13a — Gate Charge Test Circuit

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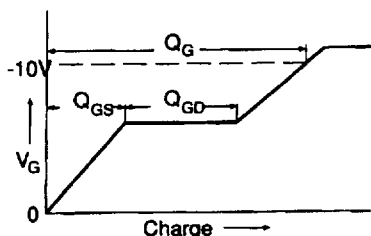
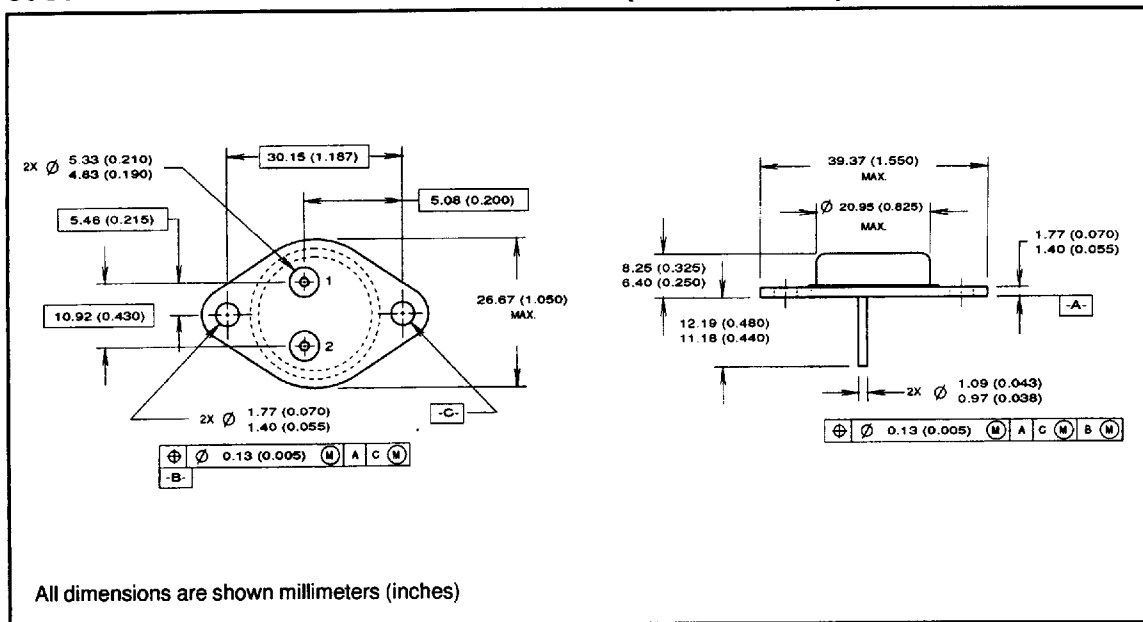


Fig. 13b — Basic Gate Charge Waveform

- ① Repetitive Rating; Pulse width limited by maximum junction temperature. (see figure 11)
- ② @  $V_{DD} = -50V$ , Starting  $T_J = 25^\circ C$ ,  
 $EAS = [0.5 \cdot L \cdot (I_L^2) \cdot [BV_{DSS}/(BV_{DSS}-V_{DD})]]$   
 Peak  $I_L = -6.5A$ ,  $V_{GS} = -10V$ ,  $25 \leq R_G \leq 200\Omega$
- ③  $ISD \leq -6.5A$ ,  $di/dt \leq -120A/\mu s$ ,  
 $V_{DD} \leq BV_{DSS}$ ,  $T_J \leq 150^\circ C$
- ④ Pulse width  $\leq 300 \mu s$ ; Duty Cycle  $\leq 2\%$
- ⑤  $K/W = ^\circ C/W$   
 $W/K = W/^\circ C$

### Case Outline and Dimensions — TO-204AA (Modified TO-3)



International  
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